Flexible Packed Stencil Design with Multiple Shaping Apertures for E-Beam Lithography

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# Introduction

- Next generation lithography solutions being actively pursued (EUV, e-beam, directed selfassembly, nanoimprint).
- Uses of e-beam
  - 1. For mask writing
  - 2. E-beam direct write
    - directly write on wafer
    - avoid ever-increasing mask cost
    - has very high resolution and no depth of focus problem
- Our objective: maximize e-beam writing throughput

#### **E-beam Writing with Character Projection**

- Character projection method
  - Patterns that occur many times in a die are made into a set of characters on a stencil
  - Then one shot can print a complex pattern rather than a single rectangle



#### **Character Projection Reduces Shot Count**



(a) As a character on the stencil, the whole pattern can be printed in 1 shot.

(b)Otherwise, requires 4 shots using variableshaped beam (VSB) mode.

## **Traditional Stencil Design**



- Stencil size is limited.
- Traditionally, stencil as a 2D-array for holding characters.
- Pick and place the *N* most beneficial characters into *N* pre-designated spots on the stencil.

#### Flexible Packed Stencil Design w/ Multiple Shaping Apertures

- Increase # chars on stencil by
  - using multiple shaping apertures (smaller characters can use smaller shaping apertures)
  - flexible bank space sharing

3 different sized shaping apertures



#### Flexible Packed Stencil Design w/ Multiple Shaping Apertures

• Flexible blank space sharing packs characters in the smallest space.



(a) Traditional packing of chars on a stencil.(b) Previous works pack chars in smaller space.(c) Our work pack chars in the smallest space.

## **Problem Formulation**

- Given
  - K: # of shaping apertures allowed
  - C: set of char candidates for a cell-based circuit (each char corr. to a particular orientation of a standard cell)
  - Dimensions of stencil
- How to
  - determine optimal widths for the *K* shaping apertures
  - choose an optimal subset of chars from C and flexibly pack them on the stencil w/ blank space sharing
  - in order to minimize total shot count for printing the circuit?

## Good and Bad News

- Bad news
  - Flexible packed stencil design is NP-hard.
- Good news
  - Tight linear packing is near optimal and can be computed efficiently.



Non-tight packing



Tight packing (blank spaces of adjacent chars completely overlap)

# Our Algorithm

- 1. Determine *K* projection region widths & select a subset of chars to be put on stencil by dynamic programming.
- 2. Assign chars selected in Step 1 to rows on the stencil & construct a tight linear packing for each row.
- 3. Greedily pack some of the unselected chars at the end of each row, if possible.

# Challenges for DP Formulation

 O(2 |C|) runtime and memory requirement just to determine whether to include each char in stencil.

-|C| > 1000 (over 1000 cell types used in a circuit)

- Want to simultaneously determine the projection width used by each chosen char s.t. # different projection widths used ≤ K.
- Width consumed by a set of chars is not equal to their total width (also depends on projection width used by each char & amount of blank space sharing).





## **Useful Properties**

- Let *w*<sub>c</sub> be the width of char *c*.
- Let *S* be the safety margin.
- 1. Projection width for char *c* must be  $\ge w_c + 2S$



To choose *K* optimal projection region widths *e1, ..., ек*, suffice to consider *ei = wc* +2*S* for some *c*. (# distinct widths in a cell library is limited.)

### **Useful Properties**

- Let *Ec* be the projection region width used by *c*.
- 3. Effective width of *c* in a tight linear packing is

 $W_{c} + (E_{c} - W_{c})/2 = (W_{c} + E_{c})/2$ 



4. If *m* chars are ordered s.t.  $E_i - w_i \le E_{i+1} - w_{i+1}$  for i = 1, ..., m-1, then a tight linear packing can be constructed in that order.

Proof: By induction

#### **Useful Properties**

5. There exists an optimal solution s.t.

 $Wc \leq Wd \Leftrightarrow Ec \leq Ed$ 



- For chars with same width, one that produces a higher shot saving should be included in stencil with higher priority.
  - Shot saving of including char *c* is  $r_c(n_{VSBc}-1)$  where  $r_c = \#$  times *c* appears in the circuit  $n_{VSBc} = \#$  shots to print *c* by VSB

# **Our DP Formulation**

- Take advantage of these properties.
- Character Grouping technique
  - Avoid considering each char separately.
  - Group all chars according to width.
  - Sort chars in each group in decreasing shot saving.
  - For each group *G*, there are only |*G*|+1 possible choices (i.e., include first *i* chars of G where *i* = 0 to |*G*|)
  - Process the groups in decreasing order of their char widths (so no group ever use a projection width larger than that of a previous group).

## **Experimental Results**

- Benchmarks
  - 1D-1 to 1D-4 (1000 chars each) from E-BLOW in DAC'2013
  - 1D-1h to 1D-4h (1200chars each)
- Stencil size: 1000µm X 1000µm
- Memory requirement
  - without character grouping technique, >18GB in some cases
  - with character grouping technique, < 0.5GB in each case</li>
- Maximum runtime ~40s (Linux server w/ 2.67GHz CPU)

## **Experimental Results**

	E-BLOW		Ours (K=1)		Ours (K=2)	
	#shots	#chars	#shots	#chars	#shots	#chars
1D-1	29536	934	12972	980	10418	1000
1D-2	44544	863	28594	895	10418	1000
1D-3	78704	758	55761	797	30785	902
1D-4	107460	699	79275	734	44468	837
Normalized	1.65	0.955	1	1	0.57	1.102

	Ours (K=1 #shots	l) #chars	Ours (K=2 #shots	2) #chars	Ours (K= #shots	=3) #chars
1D-1h	58648	980	26467	1114	17534	1163
1D-2h	86176	905	48891	1018	39630	1068
1D-3h	135332	800	93109	916	75709	948
1D-4h	169105	739	116219	855	98204	886
Normalized	1	1	0.598	1.141	0.475	1.188

# Conclusions

- Developed an efficient algorithm for flexible packed stencil design w/ multiple shaping apertures by taking note of several useful properties.
- # e-beam shots to print a circuit is greatly reduced by
  - Selecting optimal shaping aperture size(s)
  - Using multiple shaping apertures
  - Flexible blank space sharing
- Directly applicable to multi-beam direct write system.